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SHEET 1 OF 1

LIST C	F ART CITE	ATTY. DOCKET NO. HI-0177		APPLN. SERIAL NO. 10/747,945				
(DTO 1440)				APPLICANT(S) Se Woong PARK				
(PTO-1449)				FILING DATE December 31, 2003		GROUP 285'		
		U.S.	PATENT DO	UMENTS				
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME		CLASS	SUBCLASS FILING DATE		
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		FOREIC	ON PATENT D	OCUMENTS	<del></del>			
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY		CLASS	SUBCLASS	Trans Yes	No No
/JM/	CN 1328309	12/26/2001		China (Full Chinese Text)				
/JM/	EP 1 139 301	10/04/2001	Europe (Full English Text; English language patent in family of CN1328309)				х	
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OTHE	R ART (Including				, Place of	Publication,	Etc.)	
/JM/	Chinese Office							
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EXAMINER /John Morehead/				DATE CONSIDERED 04/23/2007				

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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